

# HGTP14N36G3VL, HGT1S14N36G3VL, HGT1S14N36G3VLS

December 2001

14A, 360V N-Channel, Logic Level, Voltage Clamping IGBTs

# Features

- · Logic Level Gate Drive
- Internal Voltage Clamp
- ESD Gate Protection
- T<sub>1</sub> = 175°C
- Ignition Energy Capable

# Description

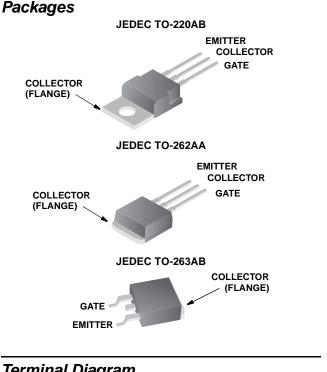
This N-Channel IGBT is a MOS gated, logic level device which is intended to be used as an ignition coil driver in automotive ignition circuits. Unique features include an active voltage clamp between the collector and the gate which provides Self Clamped Inductive Switching (SCIS) capability in ignition circuits. Internal diodes provide ESD protection for the logic level gate. Both a series resistor and a shunt resister are provided in the gate circuit.

PACKAGING	AVAILABILITY

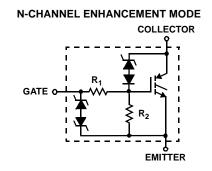
PART NUMBER	PACKAGE	BRAND
HGTP14N36G3VL	TO-220AB	14N36GVL
HGT1S14N36G3VL	TO-262AA	14N36GVL
HGT1S14N36G3VLS	TO-263AB	14N36GVL

NOTE: When ordering, use the entire part number. Add the suffix 9A to obtain the TO-263AB variant in the tape and reel, i.e., HGT1S14N36G3VLS9A.

The development type number for this device is TA49021.



# **Terminal Diagram**



# Absolute Maximum Ratings T<sub>C</sub> = +25°C, Unless Otherwise Specified

	HGTP14N36G3VL, HGT1S14N36G3VL, HGT1S14N36G3VLS	UNITS
Collector-Emitter Bkdn Voltage at 10mA BV <sub>CER</sub>	390	V
Emitter-Collector Bkdn Voltage at 10mA BV <sub>ECS</sub>	24	V
Collector Current Continuous at $V_{GE} = 5V$ , $T_C = +25^{\circ}C$ $I_{C25}$	18	А
at $V_{GE} = 5V$ , $T_{C} = +100^{\circ}C$ $I_{C100}$	14	А
Gate-Emitter Voltage (Note)	±10	V
Inductive Switching Current at L = 2.3mH, T <sub>C</sub> = +25°C I <sub>SCIS</sub>	17	А
at L = 2.3mH, T <sub>C</sub> = + 175°C	12	А
Collector to Emitter Avalanche Energy at L = 2.3mH, $T_C = +25^{\circ}CE_{AS}$	332	mJ
Power Dissipation Total at $T_c = +25^{\circ}C$ $P_D$	100	W
Power Dissipation Derating $T_{C} > +25^{\circ}C$	0.67	W/ºC
Operating and Storage Junction Temperature Range	-40 to +175	°C
Maximum Lead Temperature for SolderingTL	260	°C
Electrostatic Voltage at 100pF, 1500Ω ESD	6	KV
NOTE: May be exceeded if Land is limited to 10mA		

NOTE: May be exceeded if I<sub>GEM</sub> is limited to 10mA.

**Electrical Specifications**  $T_{C}$  = +25°C, Unless Otherwise Specified

					LIMITS		
PARAMETERS	SYMBOL	TEST CO	MIN	ТҮР	MAX	UNITS	
Collector-Emitter Breakdown Voltage	BV <sub>CER</sub>	$I_{\rm C} = 10 {\rm mA},$	T <sub>C</sub> = +175°C	320	355	400	V
		$V_{GE} = 0V$ $R_{GE} = 1k\Omega$	T <sub>C</sub> = +25 <sup>o</sup> C	330	360	390	V
			$T_{\rm C} = -40^{\rm o}{\rm C}$	320	350	385	V
Gate-Emitter Plateau Voltage	V <sub>GEP</sub>	I <sub>C</sub> = 7A, V <sub>CE</sub> = 12V	T <sub>C</sub> = +25°C	-	2.7	-	V
Gate Charge	Q <sub>G(ON)</sub>	I <sub>C</sub> = 7A, V <sub>CE</sub> = 12V	T <sub>C</sub> = +25°C	-	24	-	nC
Collector-Emitter Clamp Breakdown Voltage	BV <sub>CE(CL)</sub>	$I_{\rm C} = 7A$ $R_{\rm G} = 1000\Omega$	T <sub>C</sub> = +175°C	350	380	410	V
Emitter-Collector Breakdown Voltage	BV <sub>ECS</sub>	I <sub>C</sub> = 10mA	T <sub>C</sub> = +25°C	24	28	-	V
Collector-Emitter Leakage Current	I <sub>CER</sub>	V <sub>CE</sub> = 250V	T <sub>C</sub> = +25 <sup>o</sup> C	-	-	25	∝A
		$R_{GE} = 1k\Omega$	T <sub>C</sub> = +175°C	-	-	250	∝A
V <sub>GE</sub>	I <sub>C</sub> = 7A V <sub>GE</sub> = 4.5V	T <sub>C</sub> = +25°C	-	1.25	1.45	V	
		V <sub>GE</sub> = 4.5V	T <sub>C</sub> = +175°C	-	1.15	1.6	V
		I <sub>C</sub> = 14A V <sub>GE</sub> = 5V	T <sub>C</sub> = +25°C	-	1.6	2.2	V
		V <sub>GE</sub> = 5V	T <sub>C</sub> = +175°C	-	1.7	2.9	V
Gate-Emitter Threshold Voltage	V <sub>GE(TH)</sub>	$I_{C} = 1mA$ $V_{CE} = V_{GE}$			1.8	2.2	V
Gate Series Resistance	R <sub>1</sub>		T <sub>C</sub> = +25°C	-	75	-	Ω
Gate-Emitter Resistance	R <sub>2</sub>		T <sub>C</sub> = +25°C	10	20	30	kΩ
Gate-Emitter Leakage Current	I <sub>GES</sub>	$V_{GE} = \pm 10V$		±330	±500	±1000	∝A
Gate-Emitter Breakdown Voltage	BV <sub>GES</sub>	I <sub>GES</sub> = ±2mA	$I_{GES} = \pm 2mA$		±14	-	V
Current Turn-Off Time-Inductive Load	t <sub>D(OFF)</sub> I + t <sub>F(OFF)</sub> I	$\begin{split} & I_{C} = 7A,  R_{L} = 28\Omega \\ & R_{G} = 25\Omega,  L = 550 {\sim} H, \\ & V_{CL} = 300V,  V_{GE} = 5V, \\ & T_{C} = +175^{\circ}C \end{split}$		-	7	-	~\$
Inductive Use Test	I <sub>SCIS</sub>	L = 2.3mH, V <sub>G</sub> = 5V,	T <sub>C</sub> = +175°C	12	-	-	Α
		vG = 5v,	$T_{\rm C}$ = +25°C	17	-	-	A
Thermal Resistance	$R_{ extsf{ heta}JC}$		•	-	-	1.5	°C/W

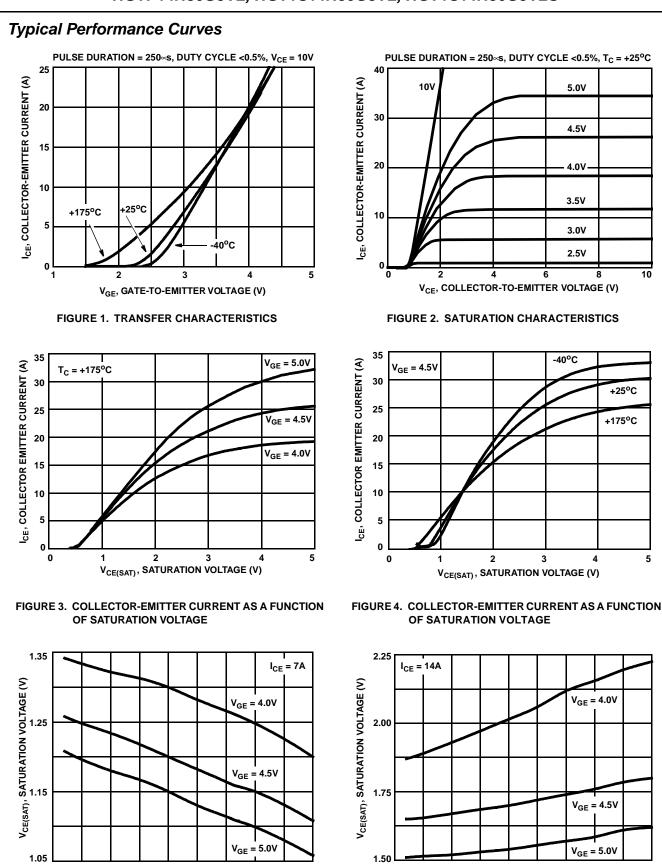


FIGURE 5. SATURATION VOLTAGE AS A FUNCTION OF JUNCTION TEMPERATURE

+25

+75

T.I., JUNCTION TEMPERATURE (°C)

+125

+175

-25

+25

JUNCTION TEMPERATURE

FIGURE 6. SATURATION VOLTAGE AS A FUNCTION OF

HGTP14N36G3VL, HGT1S14N36G3VL, HGT1S14N36G3VLS Rev. B

+75

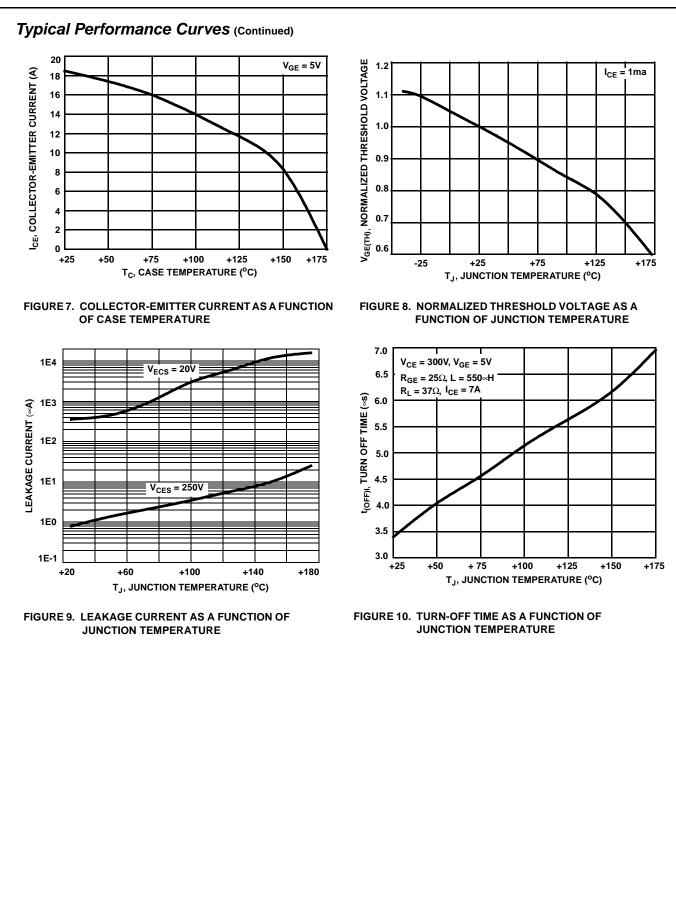
T<sub>J</sub>, JUNCTION TEMPERATURE (°C)

+175

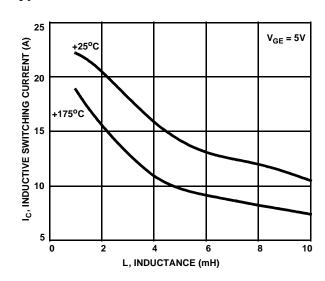
+125

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-25



# Typical Performance Curves (Continued)





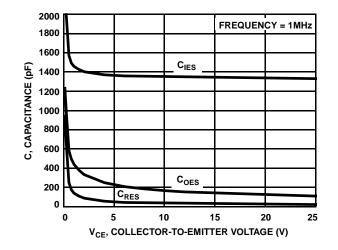
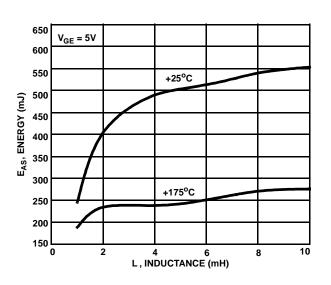


FIGURE 13. CAPACITANCE AS A FUNCTION OF COLLECTOR-EMITTER VOLTAGE





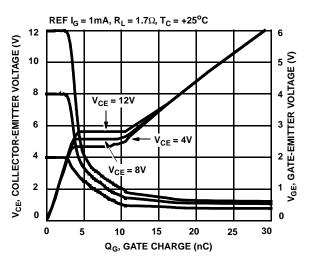
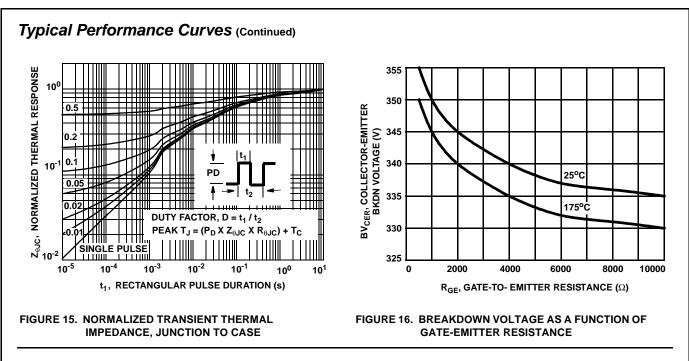


FIGURE 14. GATE CHARGE WAVEFORMS



**Test Circuits** 

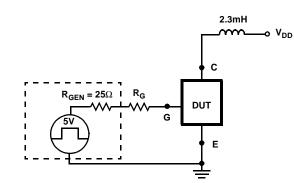


FIGURE 17. SELF CLAMPED INDUCTIVE SWITCHING CURRENT TEST CIRCUIT

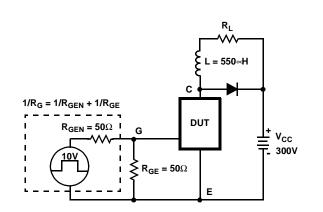


FIGURE 18. CLAMPED INDUCTIVE SWITCHING TIME TEST CIRCUIT

# Handling Precautions for IGBT's

Insulated Gate Bipolar Transistors are susceptible to gateinsulation damage by the electrostatic discharge of energy through the devices. When handling these devices, care should be exercised to assure that the static charge built in the handler's body capacitance is not discharged through the device. With proper handling and application procedures, however, IGBT's are currently being extensively used in production by numerous equipment manufacturers in military, industrial and consumer applications, with virtually no damage problems due to electrostatic discharge. IGBT's can be handled safely if the following basic precautions are taken:

1. Prior to assembly into a circuit, all leads should be kept

shorted together either by the use of metal shorting springs or by the insertion into conductive material such as †"ECCOSORBD LD26" or equivalent.

- 2. When devices are removed by hand from their carriers, the hand being used should be grounded by any suitable means for example, with a metallic wristband.
- 3. Tips of soldering irons should be grounded.
- 4. Devices should never be inserted into or removed from circuits with power on.
- Gate Voltage Rating -The gate-voltage rating of V<sub>GEM</sub> may be exceeded if I<sub>GEM</sub> is limited to 10mA.
- † Trademark Emerson and Cumming, Inc

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4,364,073	4,417,385	4,430,792	4,443,931	4,466,176	4,516,143	4,532,534	4,567,641
4,587,713	4,598,461	4,605,948	4,618,872	4,620,211	4,631,564	4,639,754	4,639,762
4,641,162	4,644,637	4,682,195	4,684,413	4,694,313	4,717,679	4,743,952	4,783,690
4,794,432	4,801,986	4,803,533	4,809,045	4,809,047	4,810,665	4,823,176	4,837,606
4,860,080	4,883,767	4,888,627	4,890,143	4,901,127	4,904,609	4,933,740	4,963,951
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	Formative or In Design First Production Full Production

Rev. H4



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# HGT1S14N36G3VLS

14A, 380V Logic Level, Voltage Clamped, Avalanche Energy Rated, ESD Protected IGBT

#### Contents

General description
Features
Product status/pricing/packaging
Order Samples

•Qualification Support



Datasheet

datasheet

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### **General description**

This N-Channel IGBT is a MOS gated, logic level device which is intended to be used as an ignition coil driver in auto-motive ignition circuits. Unique features include an active voltage clamp between the collector and the gate which pro-vides Self Clamped Inductive Switching (SCIS) capability in ignition circuits. Internal diodes provide ESD protection for the logic level gate. Both a series resistor and a shunt resister are provided in the gate circuit.

Formerly Developmental Type TA49021.

#### back to top

#### Features

- Logic Level Gate Drive
- Internal Voltage Clamp
- ESD Gate Protection
- T<sub>J</sub> = 175°C
- Ignition Energy Capable

#### back to top

Product status/pricing/packaging





Request samples

How to order products

\_\_\_\_\_

Product Change Notices (PCNs)

·····

<u>Support</u>

Sales support

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This page Print version

Product	Product status	Pb-free Status	Pricing*	Package type	Leads	Packing method	Package Marking Convention**
HGT1S14N36G3VLS	Full Production	Full Production	\$2.58	TO-263(D2PAK)	2	RAIL	Line 1: <b>\$Y</b> (Fairchild logo) & <b>Z</b> (Asm. Plant Code) & <b>3</b> (3-Digit Date Code) & <b>T</b> (Die Trace Code) Line 2: 14N36GVL
HGT1S14N36G3VLT	Full Production	Full Production	\$2.64	TO-263(D2PAK)	2	TAPE REEL	Line 1: <b>\$Y</b> (Fairchild logo) & <b>Z</b> (Asm. Plant Code) & <b>3</b> (3-Digit Date Code) & <b>T</b> (Die Trace Code) Line 2: 14N36GVL

\* Fairchild 1,000 piece Budgetary Pricing
\*\* A sample button will appear if the part is available through Fairchild's on-line samples program. If there is no sample button, please contact a <u>Fairchild distributor</u> to obtain samples

Indicates product with Pb-free second-level interconnect. For more information click here.

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## back to top

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Click on a product for detailed qualification data

Product
HGT1S14N36G3VLS
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## back to top

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